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|-----------------------------------|--|-------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination 10/080,619 IMADA ET AL. | |
| | | Examiner | Art Unit BINH Q. TRAN 3748 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-6,220,018 B1 | 04-2001 | Yamanashi et al. | 60/285 |
| | B | US-6,490,859 B2 | 12-2002 | Kakuyama et al. | 60/285 |
| | C | US-6,170,260 B1 | 01-2001 | Ishii et al. | 60/297 |
| | D | US-6,047,544 A | 04-2000 | Yamamoto et al. | 60/285 |
| | E | US-6,601,383 B2 | 08-2003 | Hasegawa et al. | 60/276 |
| | F | US-6,185,933 B1 | 02-2001 | Tsuzuki et al. | 60/285 |
| | G | US-5,979,157 A | 11-1999 | Kinugasa et al. | 60/274 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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